

Correlation between the UV-reflectance spectra and the structure of poly-Si films obtained by aluminium induced crystallization

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Influence of differently formed interfacial aluminium oxide on the structural properties of poly-Si films prepared by aluminium induced crystallisation

Dimova-Malinovska, D.; Nichev, H.; Angelov, O.; Sendova-Vassileva, M.; Sendova, M.; **Mikli, Valdek** Journal of optoelectronics and advanced materials 2007 / 2, p. 359-362

Room temperature sensitivity of Ta doped nanocrystalline ZnO films to NH₃ exposure

Nichev, H.; Angelov, O.; Kamenova, M.; **Mikli, Valdek**; Dimova-Malinovska, D. Journal of optoelectronics and advanced materials 2009 / 10, p. 1371-1374
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Sensitivity of ZnO films doped with Er, Ta and Co to NH₃ at room temperature

Dimova-Malinovska, D.; Nichev, H.; Georgieva, V.; Angelov, O.; Pivin, J.-C.; **Mikli, Valdek** Physica status solidi (a) : applications and materials science 2008 / 8, p. 1993-1997 : ill https://link.springer.com/chapter/10.1007/978-1-4020-9916-8_32